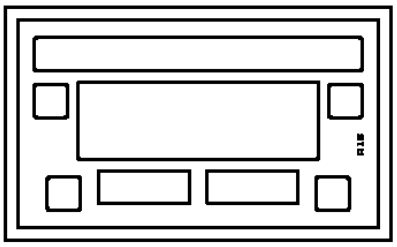
GD020 50V, DC – 7.0GHz, 20W GaN HEMT

FEATURES

- Operating Frequency Range: DC to 7.0GHz
- Operating Drain Voltage: 28V & 50V
- Maximum Output Power (P_{SAT}): 30W
- Bare die shipped in Gel-Pak containers
- Suitable for CW, Pulsed, Linear applications
- 100% KGD DC Production Tested



1.26 x 0.75 mm Die

DESCRIPTION

The GD020 is a 30W (P3dB) unmatched discrete GaN-on-SiC HEMT which operates from DC to 7.0GHz on a 50V supply rail. The wide bandwidth of the GD020 makes it suitable for a variety of applications including cellular infrastructure, radar, communications, and test instrumentation, and can support CW, linear and pulse operations.

Bare die are shipped in Gel-Pak containers for safe transport and storage.

Typical Performances Measured Loadpull 1 Tone pulsed CW (10% duty cycle, 100µs width) in DFN 6x3 package, *2nd Harmonics NOT optimized*

(1) Optimum Peak Power at 2.5dB in compression
(2) Optimum Peak Efficiency at 2.5dB in compression

Vds=50V, Idq= 47 mA, T_A = 25°C

Frequency (MHz)	Pout(1) (dBm)	Gain(2) (dB)	Eff(2) (%)
1000	46.2	23.7	65.2
1400	46.6	21.5	67.7
1800	46.7	20.8	64.7
2200	46.8	20.3	61.9
2600	46.9	18.9	66.1
3000	46.9	18.7	64.8
4000	46.9	17	64.5
5000	46.6	14.2	59.7
6000	46.8	13.5	60.8

Vds=28V, Idq= 47 mA, T_A = 25°C

Frequency (MHz)	Pout(1) (dBm)	Gain(2) (dB)	Eff(2) (%)
1000	43.7	20.2	68.9
1400	44.2	19.9	68
1800	44.4	19.4	66.9
2200	44.2	18.7	64
2600	44.4	17.1	68
3000	44.4	16.9	66.7
4000	44.3	14.9	65.7
5000	44	12.8	61.3
6000	44.2	11.3	63.3

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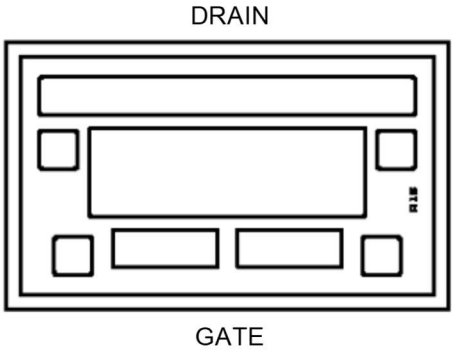
ABSOLUTE MAXIMUM RATINGS(1, 2)

Parameter	Rating	Symbols and Units
Drain Source Voltage	150	V_{DS} (V)
Gate Source Voltage	-8 to +2	V_{GS} (V)
Operating Voltage	55	V_{dsq} (V)
Junction Temperature	+225	T_{JUNC}(°C)
Storage Temperature	-65 to +150	$T_{STORAGE}$(°C)

1. Exceeding any of these limits may cause permanent damage to this device or seriously limit the life time (MTTF)
2. GalliumSemi does not recommend sustained operation above maximum operating conditions.

BLOCK DIAGRAM



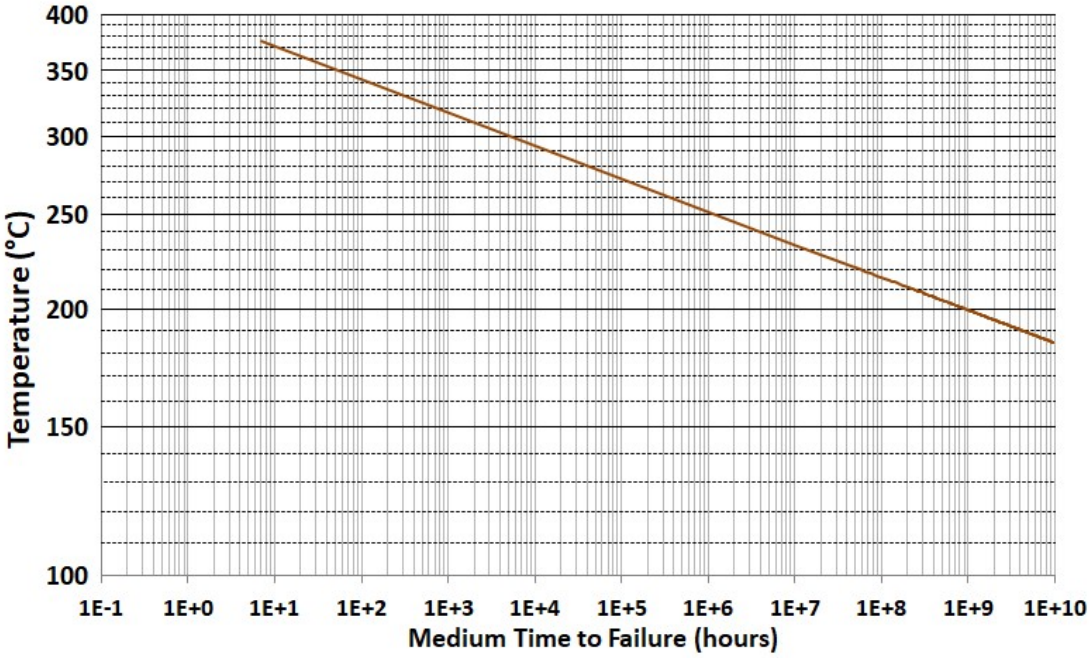
ELECTRICAL SPECIFICATIONS: T_A = 25°C

Parameter	Min.	Typ.	Max.	Symbols and Units	Test conditions
Frequency Range	DC		7000	MHz	
DC Characteristics					
Drain Source Breakdown Voltage	150			V_{BDSS} (V)	
Drain Source Leakage Current		1.27		I_{DLK} (mA)	Vgs = -8V, Vds = 50V
Gate Threshold Voltage	-3.4		-1.5	V_{GS} (V)	Vds = 50V
Operating Conditions					
Gate Bias Voltage		-2.5		V_{GSQ} (V)	
Drain Voltage		50		V_{DSQ} (V)	
Quiescent Drain Current		31		I_{DQ} (mA)	

THERMAL AND RELABILITY INFORMATION -CW [1, 2]: T_c = 85°C

Parameter	Test condition	Value	Units	Notes
Channel Temperature, Tch	Pdiss 6 W	124.1	°C	
Rth die		3.9	ºC/W	
MTTF		>1.0E+10	Hrs	
Channel Temperature, Tch	Pdiss 12 W	168	°C	
Rth die		4.2	ºC/W	
MTTF		>1.0E+10	Hrs	
Channel Temperature, Tch	Pdiss 18 W	220	°C	
Rth die		4.8	ºC/W	
MTTF		6.0E+07	Hrs	

1.Assumes eutectic attach using 1mil low temp solder, mounted to a 8 mil DFN package.
2:Thermal Resistance using Finite Element Analysis (FEA) simulation, calibrated with Infrared measurement on surface temperature.



LOADPULL MEASUREMENT, Vds= 50V Idq = 47 mA

Die packaged in DFN 6x3, Measured 1 Tone Pulse CW, pulse width 100us, duty cycle 10%

For Optimum Peak Power @ 2.5dB Compression

Freq-MHz	Zin_F0	Zl_F0	Gain-dB	Pout-dBm	Pout-W	Eff-%	AMPM-deg
1000	4.2 j -13.2	21.1 j 4.4	22.6	46.2	42.3	58.4	1
1200	3.0 j -11.0	17.4 j 7.7	22.3	46.5	45.4	60.4	1.8
1400	2.5 j -8.7	16.3 j 7.9	21.7	46.6	46.2	60.2	2
1600	2.5 j -7.3	12.8 j 4.8	19.5	47	50.2	54.5	3.2
1800	1.9 j -5.5	15.2 j 5.8	19.9	46.7	47.2	55.6	2.3
2000	2.3 j -4.6	14.0 j 4.1	18.9	46.6	45.6	50.8	2.2
2200	1.8 j -3.3	13.9 j 4.6	18.1	46.8	47.6	53.1	2.7
2400	1.6 j -2.1	12.5 j 7.1	18	46.7	46.4	56.6	3.1
2800	1.7 j -0.3	11.5 j 5.2	17.7	47	50.6	57	1.1
3000	1.7 j 0.6	11.6 j 3.0	16.8	46.9	49	53.1	0.8
3500	1.8 j 2.6	9.3 j 1.4	15.5	46.8	48.1	50.2	-0.2
4000	1.7 j 4.7	7.9 j 1.1	15.3	46.9	48.7	53.7	-1.3
4500	1.7 j 6.5	7.7 j -1.0	13.4	46.7	47.5	48.6	-1.9
5000	1.8 j 9.1	7.0 j -0.5	13.7	46.6	46.2	54.5	-1.9
5500	2.0 j 10.5	6.1 j -2.5	12.7	46.7	47	54.9	-1.8
6000	2.5 j 14.3	7.2 j -5.0	11.8	46.8	48.4	52.5	-1.1

For Optimum Peak Efficiency @ 2.5dB Compression

Freq-MHz	Zin_F0	Zl_F0	Gain-dB	Pout-dBm	Pout-W	Eff-%	AMPM-deg
1000	2.6 j -11.5	24.9 j 13.0	23.7	45.9	38.9	65.2	-0.9
1200	2.5 j -9.8	20.9 j 14.0	23.1	46.1	40.7	65.8	0.5
1400	2.2 j -7.4	22.8 j 18.4	21.5	45.7	37.7	67.7	3.4
1600	2.1 j -5.1	17.5 j 19.1	21.1	45.4	34.9	68.3	-0.6
1800	1.7 j -4.3	15.9 j 14.7	20.8	46.1	41.4	64.7	2.2
2000	2.1 j -3.5	18.0 j 16.4	19.4	45.9	38.7	61.9	4.2
2200	1.4 j -2.4	12.9 j 12.4	20.3	46.2	41.3	61.9	1.6
2400	1.2 j -1.1	10.6 j 14.0	19.7	45.6	36.2	61.2	1.6
2800	1.3 j 0.6	9.1 j 13.5	18.4	45.7	37.4	65.1	1.5
3000	1.1 j 1.8	8.9 j 12.4	18.7	45.5	35.6	64.8	0.2
3500	1.1 j 3.7	5.8 j 7.2	17.6	45.8	38.7	63.4	-1.2
4000	1.0 j 5.7	4.9 j 5.9	17	45.5	35.5	64.5	-2.1
4500	1.3 j 7.3	4.4 j 3.6	15.4	45.7	37.3	61.8	-1.9
5000	1.3 j 9.6	4.7 j 1.1	14.2	45.9	39.4	59.7	-2.7
5500	1.5 j 11.3	3.0 j -0.3	13.9	44.8	30.2	60.7	-2.7
6000	1.8 j 15.1	3.5 j -2.2	13.5	45.4	34.9	60.8	-0.9

LOADPULL MEASUREMENT, Vds= 28V Idq = 47 mA

Die packaged in DFN 6x3, Measured 1 Tone Pulse CW, pulse width 100us, duty cycle 10%

For Optimum Peak Power @ 2.5dB Compression

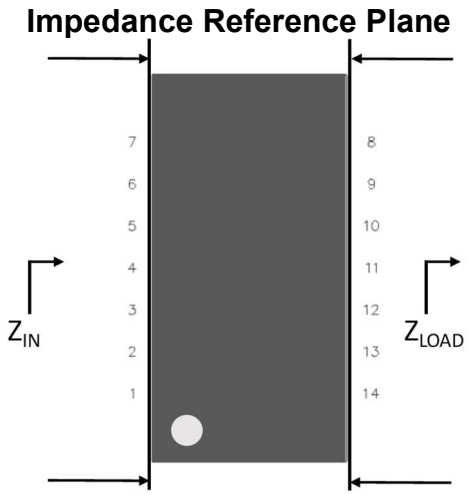
Freq-MHz	Zin_F0	Zl_F0	Gain-dB	Pout-dBm	Pout-W	Eff-%	AMPM-deg
1000	4.6 j -13.3	12.2 j -2.2	20.6	43.7	23.3	55.2	0.4
1200	3.7 j -11.0	12.3 j -1.0	19.7	43.9	24.8	57.1	1.4
1400	2.9 j -8.8	11.5 j 0.8	18.8	44.2	26.5	60.7	3.5
1600	2.9 j -7.1	10.4 j -0.8	18	44.4	27.4	56.1	0.6
1800	2.3 j -5.5	11.0 j 0.2	18.3	44.4	27.3	57.7	1.1
2000	2.1 j -4.3	11.5 j 0.7	17.8	44.1	25.8	56	1.6
2200	2.0 j -3.2	10.8 j -0.7	17	44.2	26.5	54.9	1.1
2400	1.8 j -2.1	10.7 j 0.3	16.8	44.2	26.1	56.1	0.7
2800	1.4 j 0.0	9.9 j 0.7	16.2	44.4	27.7	60.1	0.2
3000	1.5 j 0.9	9.4 j 0.3	16.4	44.4	27.5	60.4	-1.3
3500	1.6 j 2.9	7.9 j -1.0	15	44.4	27.2	58.1	-1.9
4000	1.4 j 5.1	7.1 j -1.3	14.5	44.3	26.8	60.9	-2.9
4500	1.9 j 6.7	8.2 j -3.9	12.4	44.2	26.1	53.6	-2.3
5000	1.4 j 9.5	5.9 j -4.7	12	44	25.4	57.2	-3.4
5500	1.8 j 10.9	6.6 j -6.1	10.9	44	25.9	57.3	-2.7
6000	2.2 j 14.8	7.9 j -7.1	10.6	44.2	26.5	58	-1.3

For Optimum Peak Efficiency @ 2.5dB Compression

Freq-MHz	Zin_F0	Zl_F0	Gain-dB	Pout-dBm	Pout-W	Eff-%	AMPM-deg
1000	3.5 j -11.7	20.0 j 1.7	20.2	43	20.4	68.9	0.1
1200	2.5 j -8.5	20.1 j 7.6	20.4	42.6	18.5	67.6	2.4
1400	2.3 j -7.5	19.3 j 8.4	19.9	42.8	19.2	68	3.1
1600	2.3 j -4.8	17.9 j 10.4	18.4	42.5	17.9	68.6	0
1800	1.5 j -3.9	13.7 j 8.0	19.4	43.2	21.1	66.9	0.7
2000	1.7 j -3.4	15.2 j 7.7	18	43.3	21.6	62.8	3
2200	1.1 j -1.8	10.6 j 7.6	18.7	43.2	20.7	64	0.1
2400	1.4 j -1.3	11.0 j 8.7	17.5	42.8	19	62.7	0.9
2800	1.1 j 1.2	9.3 j 8.1	16.8	42.9	19.6	67	-0.5
3000	1.0 j 2.1	8.7 j 7.1	16.9	42.7	18.8	66.7	-1.5
3500	1.1 j 3.5	6.6 j 2.5	15.3	43.7	23.9	66.2	-3
4000	1.1 j 5.8	6.1 j 1.9	14.9	43.2	21	65.7	-3.4
4500	1.3 j 7.7	4.6 j 0.5	13.6	42.8	19	64	-5
5000	1.3 j 9.8	5.1 j -1.8	12.8	43	19.9	61.3	-4.3
5500	1.4 j 11.5	3.7 j -4.1	11.6	42.8	19.5	63.1	-7.3
6000	1.7 j 15.4	4.2 j -6.0	11.3	43.2	21	63.3	-4.9

LOADPULL MEASUREMENT NOTES

Source and Load impedance @ 2nd Harmonic are set to 10 Ohms
With proper 2nd Harmonic termination, expect +5% Efficiency for Source and similar with Drain 2nd Harmonic.
Z_{LOAD}: Measured Impedance presented to the output of the device in the reference plane
Z_{IN}: Measured input Impedance at the input of the device in the reference plane

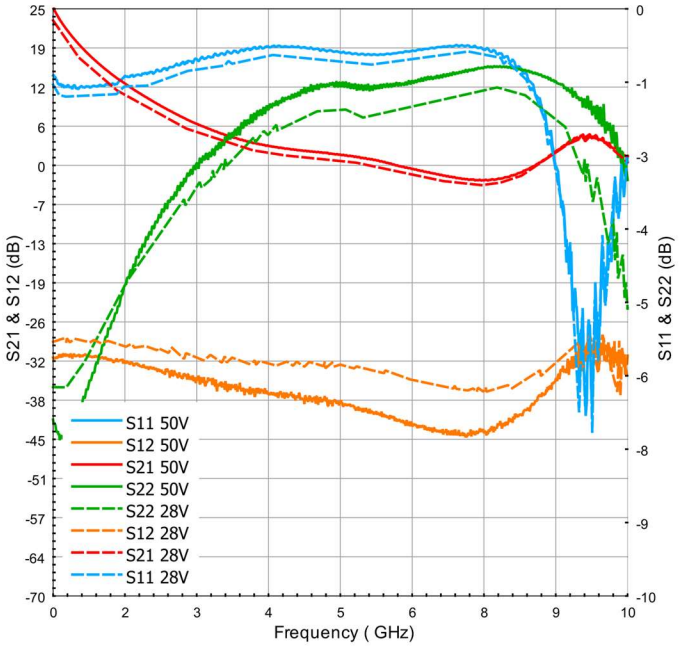


Raw data and full Loadpull measurement report available at request: sales@galliumsemi.com

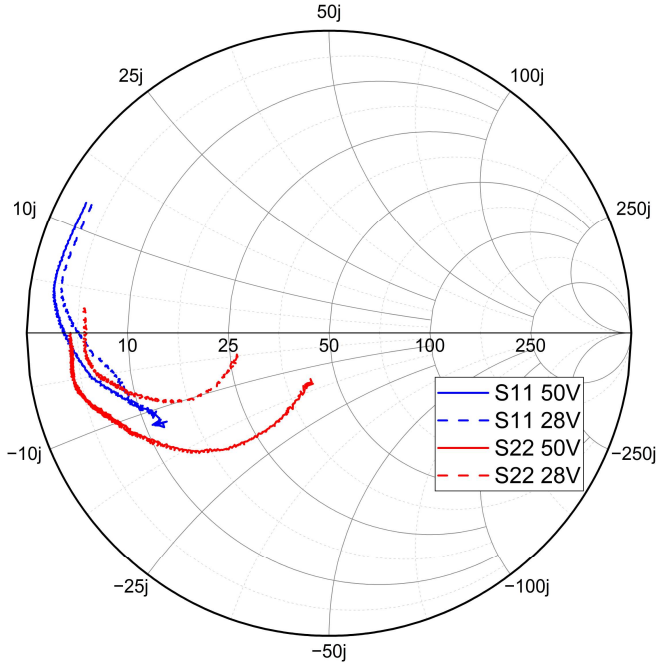
BROADBAND S-PARAMETERS MEASUREMENT, Vds= 28 & 50V Idq = 47 mA

Die packaged in DFN 6x3, Measured 1 Tone CW

S Parameters (Mag-dB)



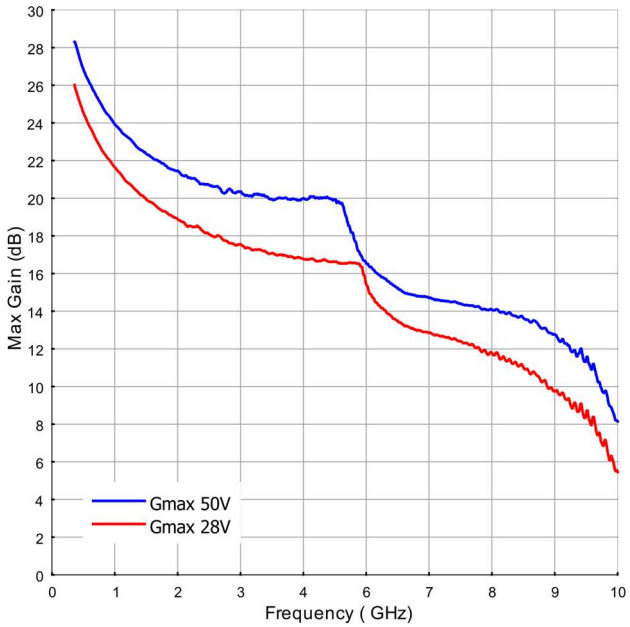
S11 & S22 0.4-6 GHz



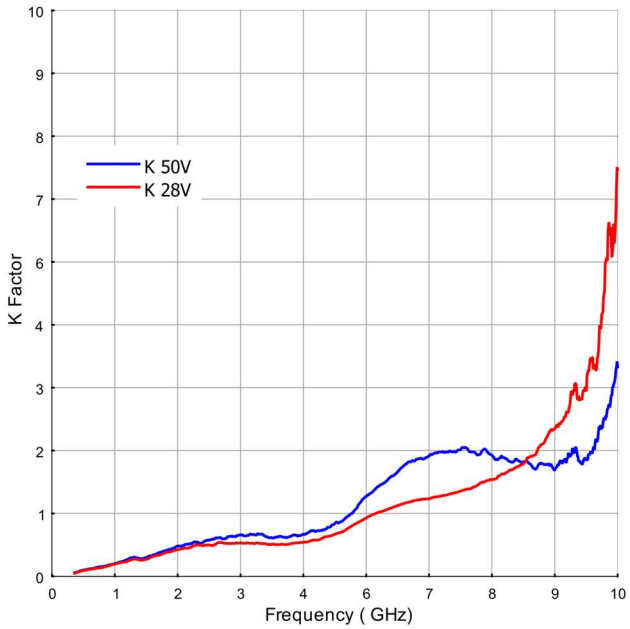
BROADBAND S-PARAMETERS MEASUREMENT, Vds= 28 & 50V Idq = 47 mA

Die packaged in DFN 6x3, Measured 1 Tone CW

Maximum Available Gain



K Factor



GaN HEMT BIASING SEQUENCE

To turn the transistor ON

1. Set V_{GS} to -5V
2. Turn on V_{DS} to normal operation voltage (50V)
3. Slowly increase V_{GS} to set I_{DQ} current (31mA)
4. Apply RF power

To turn the transistor OFF

1. Turn the RF power off
2. Decrease V_{GS} to -5V
3. Turn off $V_{D.}$ Wait a few seconds for drain capacitor to discharge
4. Turn off V_{GS}

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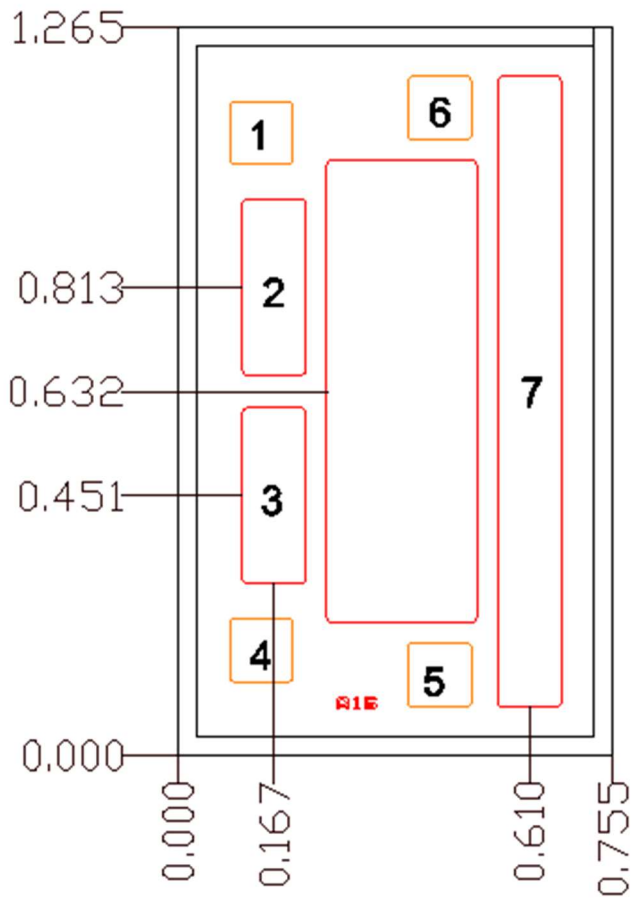
DIE DIMENSIONS



Bond Pads

Pad nb.	Description	Dimensions
1, 4, 5,6	Not connected	
2,3	RF Input / Gate Voltage	0.110 x 0.305
7	RF Output / Drain Voltage	0.110 x 1.093
Backside	Source/ Ground	0.755 x 1.265

Notes:
1. All dimensions are in millimeter
2. Die thickness is 75 um
3. Bond pad metallization: gold
4. Backside metallization: gold

HANDLING PRECAUTIONS

Parameter	Symbol	Class	Test Methodology
ESD* – Human Body Model	HBM	Class 1A (250 V)	ANSI/ESDA/JEDEC Standard JS-001
ESD* – Charged Device Model	CDM	Class C3 (1500 V)	ANSI/ESDA/JEDEC Standard JS-002

* Tested in DFN 3x6 package

CONTACT INFORMATION

To request latest information and samples, please contact us at:

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Email: sales@galliumsemi.com

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